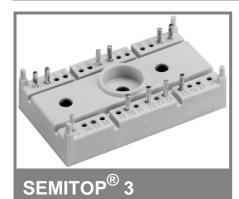
SK 30 GARL 067 E



IGBT Module

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Target Data

Features

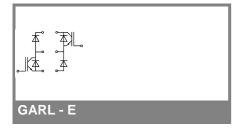
- Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Hyperfast NPT IGBT
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- Positive Vcesat temperature coefficient (Easy paralleling)
- Low tail current with low temperature dependence
- · Low threshold voltage

Typical Applications

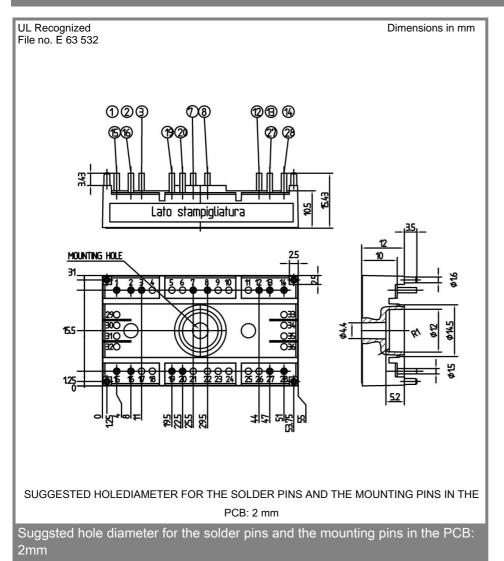
- Switching (not for linear use)
- High Frequencies Applications
- Welding Generator
- Switched mode power supplies
- UPS

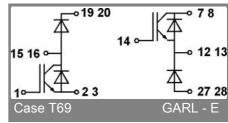
Absolute	Maximum Ratings	T _s = 25 °C, unless otherwise	T _s = 25 °C, unless otherwise specified					
Symbol	Conditions	Values	Units					
IGBT								
V_{CES}		600	V					
V_{GES}		± 20	V					
I _C	T _s = 25 (80) °C;	45 (30)	Α					
I _{CM}	$t_p < 1 \text{ ms; } T_s = 25 (80) \text{ °C;}$	90 (60)	Α					
T _j	·	- 40 + 150	°C					
Freewheeling Diode								
I _F	$T_s = 25 (80) ^{\circ}C;$	45 (30)	Α					
$I_{FM} = -I_{CM}$	$t_p < 1 \text{ ms; } T_s = 25 (80) ^{\circ}\text{C;}$	90 (60)	Α					
T _j		- 40 + 150	°C					
T _{stg}		- 40 + 125	°C					
T _{sol}	Terminals, 10 s	260	°C					
V _{isol}	AC 50 Hz, r.m.s. 1 min. / 1 s	2500 / 3000	V					

Characteristics		T _o = 25 °	T _s = 25 °C, unless otherwise specified				
Symbol Conditions		min.		max.	Units		
-	Conditions		typ.	IIIax.	Units		
IGBT	L 00 A T 05 (405) 90	ı	0.0 (0.5)		1 1/		
V _{CE(sat)}	$I_C = 60 \text{ A}, T_j = 25 (125) ^{\circ}\text{C}$		2,8 (3,5)	_	V		
V _{GE(th)}	$V_{CE} = V_{GE}$; $I_{C} = 0,0014 A$	3	4	5	V		
C _{ies}	$V_{CE} = 25 \text{ V}; V_{GE} = 0 \text{ V}; 1 \text{ MHz}$		3	0.05	nF		
$R_{th(j-s)}$	per IGBT			0,85	K/W		
	per module				K/W		
	under following conditions:						
t _{d(on)}	$V_{CC} = 400 \text{ V}, V_{GE} = \pm 15 \text{ V}$		32		ns		
t _r	I _C = 60 A, T _i = 125 °C		20		ns		
$t_{d(off)}$	$R_{Gon} = R_{Goff} = 11 \Omega$		340		ns		
t _f			30		ns		
E _{on} + E _{off}	Inductive load		3,4		mJ		
Freewhee	eling Diode	•					
	I _F = 60 A; T _i = 25 (150) °C	Ì	(1,25)	2	V		
V _(TO)	T _i = (150) °C		(1)		V		
r _T	$T_{i} = (150) ^{\circ}C$		(9)		mΩ		
R _{th(j-s)}			, ,	1,6	K/W		
11() 3)	under following conditions:						
I _{RRM}	I _F = 30 A; V _R = 400 V		18		Α		
Q _{rr}	$dI_{c}/dt = -100 \text{ A/}\mu\text{s}$		1,5		μC		
E _{off}	V _{GE} = 0 V; T _i = 125 °C		,		mJ		
Mechanic	, ,				1		
M1		2,3		2,5	Nm		
	mounting torque	2,3		2,5			
W			30		g		
Case	SEMITOP® 3		T 69				



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.